



Cite this: DOI: 10.1039/d6cc00558f

 Received 27th January 2026,  
 Accepted 27th March 2026

DOI: 10.1039/d6cc00558f

[rsc.li/chemcomm](https://rsc.li/chemcomm)

# Introducing an insulating alumina layer into a molecular photocathode to improve CO<sub>2</sub> reduction activity

 Yu Takagi,<sup>a</sup> Masaya Yara,<sup>b</sup> Toshiya Tanaka,<sup>a</sup> Jo Onodera,<sup>a</sup> Minato Tanaka,<sup>a</sup> Megumi Okazaki,<sup>ib</sup> Kiyoshi Miyata,<sup>b</sup> Ken Onda,<sup>ib</sup>\*<sup>b</sup> Osamu Ishitani,<sup>ib</sup>\*<sup>c</sup> and Kazuhiko Maeda,<sup>ib</sup>\*<sup>ad</sup>

**Interfacial engineering with an Al<sub>2</sub>O<sub>3</sub> overlayer enhances visible-light-driven CO<sub>2</sub> reduction on p-type NiO photocathodes incorporating Ru(II)-based photosensitizing molecular units. Operando transient absorption spectroscopy reveals that Al<sub>2</sub>O<sub>3</sub> suppresses charge recombination between NiO and the photosensitizer unit, prolonging carrier lifetimes and improving catalytic efficiency.**

Following the establishment of the spectral sensitization concept by Gerischer,<sup>1</sup> hybrids composed of light-absorbing molecules (*i.e.*, photosensitizers) and semiconductors have long served as fundamental building blocks for dye-sensitized solar cells (DSSCs)<sup>2</sup> and photocatalytic systems.<sup>3,4</sup> The direction of interfacial electron transfer in such hybrid systems is governed by the conduction type of the semiconductor. For instance, in systems employing n-type TiO<sub>2</sub> in combination with Ru(II)-based photosensitizers, upward band bending at the n-TiO<sub>2</sub>/solution interface facilitates electron injection from the photoexcited sensitizer into the semiconductor. By contrast, when a p-type semiconductor such as NiO is used, electron transfer from the semiconductor to the photoexcited photosensitizer becomes feasible because of downward band bending, enabling the construction of photoelectrochemical cells for water splitting<sup>5</sup> and CO<sub>2</sub> reduction.<sup>6,7</sup>

A representative example is a photocathode composed of a Ru(II)–Re(I) binuclear complex (**RuRe**) immobilized on NiO, which selectively reduces CO<sub>2</sub> to CO (Scheme S1 and Fig. S1).<sup>6</sup> **RuRe** and its analogues were originally developed as homogeneous

photocatalysts for visible-light CO<sub>2</sub> reduction.<sup>8</sup> Upon photoexcitation of **RuRe** *via* singlet metal-to-ligand charge transfer, the excited Ru unit accepts an electron from the p-type NiO substrate to generate a one-electron-reduced species. This electron is subsequently transferred to the catalytically active Re center. Repetition of this sequence enables the accumulation of two electrons at the Re site, thereby driving the two-electron reduction of CO<sub>2</sub> to CO. However, competitive back electron transfer from the reduced Ru or Re species to NiO can occur, leading to diminished CO<sub>2</sub> reduction efficiency. Consequently, precise interfacial engineering that retards charge recombination while preserving efficient electron injection is a key requirement for high-performance molecule/semiconductor hybrid photocathodes.

In n-TiO<sub>2</sub>-based DSSCs, charge recombination between the photosensitizer and the semiconductor can be effectively suppressed by conformally coating TiO<sub>2</sub> with a thin metal oxide overlayer possessing a higher conduction band edge.<sup>9</sup> Such overlayers increase the physical separation at the photosensitizer/TiO<sub>2</sub> interface, thereby retarding back electron transfer.<sup>10</sup> Although increasing this separation can also impede forward electron injection, the much slower kinetics of back electron transfer enable selective suppression of recombination without compromising the overall photofunctional performance.<sup>11</sup> Further improvements have been achieved by precisely controlling the overlayer thickness using surface engineering techniques such as atomic layer deposition.<sup>12,13</sup>

By contrast, analogous surface modification strategies for p-type semiconductors remain scarcely explored. Only four examples of metal-oxide coatings on p-type semiconductor surfaces have thus far been reported.<sup>14–17</sup> Among these, three involve p-NiO-based DSSCs; the sole example of the strategy being applied to a photocathode is the water-splitting system reported by Ji *et al.*<sup>17</sup> Notably, the influence of the oxide overlayer precursor concentration and its effect on carrier dynamics in p-type semiconductor/molecular photocatalyst hybrid systems have not yet been investigated.

<sup>a</sup> Department of Chemistry, School of Science, Institute of Science Tokyo, 2-12-1-NE-2 Ookayama, Meguro-ku, Tokyo 152-8550, Japan.

E-mail: maeda@chem.sci.isct.ac.jp

<sup>b</sup> Department of Chemistry, Faculty of Science, Kyushu University, 744 Motoooka, Nishi-ku, Fukuoka 819-0395, Japan. E-mail: konda@chem.kyushu-univ.jp

<sup>c</sup> Department of Chemistry, Graduate School of Advanced Science and Engineering, Hiroshima University, 1-3-1 Kagamiyama, Higashi-Hiroshima, Hiroshima 739-8526, Japan. E-mail: iosamu@hiroshima-u.ac.jp

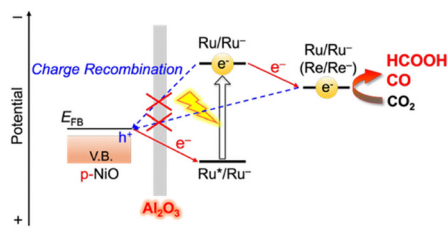
<sup>d</sup> Research Center for Autonomous Systems Materialogy (ASMat), Institute of Science Tokyo, 4259 Nagatsuta-cho, Midori-ku, Yokohama, Kanagawa 226-8501, Japan



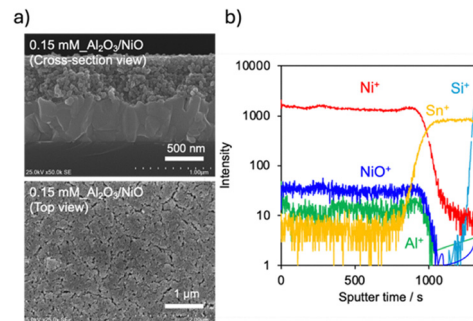
Herein, we report  $\text{Al}_2\text{O}_3$ -coated NiO electrodes further functionalized with either a Ru(II)–Re(I) binuclear complex (**RuRe**) or polymerized Ru complexes (poly-**RuRu'**) as hybrid photocathodes for visible-light-driven  $\text{CO}_2$  reduction. The  $\text{Al}_2\text{O}_3$  overlayer is introduced to suppress interfacial charge recombination (Scheme 1), and its effect on charge carrier dynamics is systematically examined using *operando* transient absorption spectroscopy.

NiO electrodes were fabricated on fluorine-doped tin oxide (FTO) substrates using a squeegee method, as reported previously.<sup>18</sup> The formation of NiO on FTO was confirmed by X-ray photoelectron spectroscopy (XPS) and X-ray diffraction (XRD) measurements (Fig. S2). The as-prepared NiO electrodes were then immersed in 2-propanol solutions containing different concentrations ( $C$ ) of aluminum tri-*sec*-butoxide, followed by heat treatment<sup>9</sup> to afford  $\text{Al}_2\text{O}_3$ -modified NiO electrodes (denoted as  $C\text{-Al}_2\text{O}_3/\text{NiO}$ ). Full experimental details are described in the SI.

Cross-sectional scanning electron microscopy combined with energy-dispersive X-ray spectrometry (SEM–EDS) of the  $0.15\text{ mM-}\text{Al}_2\text{O}_3/\text{NiO}$  electrode revealed a NiO nanoparticle layer with particle diameters of approximately 20 nm and a thickness of  $\sim 600\text{ nm}$  deposited onto the FTO substrate (Fig. 1a). Although Al species could not be detected by EDS because of their low absolute concentration (Fig. S3), depth profiling by time-of-flight secondary-ion mass spectrometry (TOF-SIMS) clearly showed  $\text{Al}^+$  signals throughout the NiO layer (Fig. 1b). The  $\text{Al}^+$  signals persisted until the appearance of  $\text{Sn}^+$  signals originating from the FTO substrate, indicating that Al species were distributed across the entire NiO nanoparticle layer. The presence of  $\text{Al}_2\text{O}_3$  was further supported by Fourier transform infrared (FT-IR) spectra (Fig. S4), which showed Al–O symmetric stretching vibration bands at the  $<1000\text{ cm}^{-1}$  region.<sup>19,20</sup> By contrast, XRD analysis did not show diffraction peaks attributable to crystalline Al-containing phases; only reflections from NiO and the FTO substrate were observed (Fig. S2a). This result suggests that the  $\text{Al}_2\text{O}_3$  deposited onto NiO is amorphous. XPS measurements indicated that the electronic state of NiO remains essentially unchanged after  $\text{Al}_2\text{O}_3$  modification, suggesting that the interaction between  $\text{Al}_2\text{O}_3$  and NiO is weak. The XPS results also indicated that direct detection of Al signals was difficult because the Al 2s region overlaps with that of Ni 2p (Fig. S2b).



**Scheme 1** Introduction of an insulating  $\text{Al}_2\text{O}_3$  layer onto NiO further functionalized with a binuclear Ru(II)–Re(I) complex (**RuRe**) or a polymerized Ru(II) complex (poly-**RuRu'**).



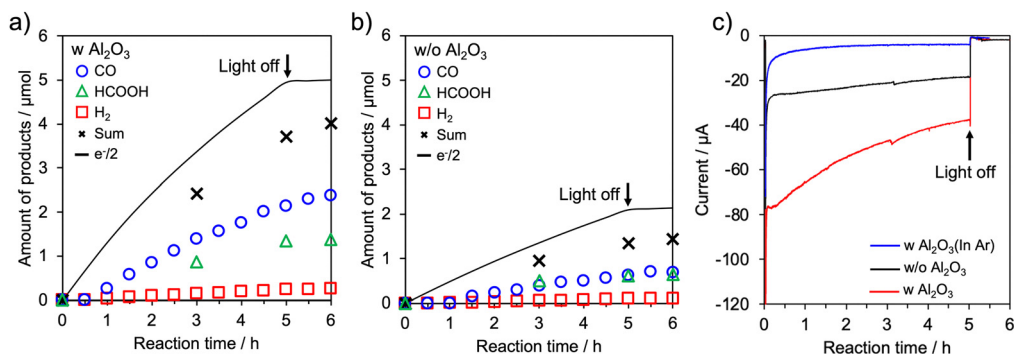
**Fig. 1** (a) SEM images and (b) TOF-SIMS spectra representing the distribution of elements in the depth direction for  $0.15\text{ mM-}\text{Al}_2\text{O}_3/\text{NiO}$ .

The surface morphologies of NiO,  $0.15\text{ mM-}\text{Al}_2\text{O}_3/\text{NiO}$ , and  $150\text{ mM-}\text{Al}_2\text{O}_3/\text{NiO}$  electrodes were examined by atomic force microscopy (AFM) (Fig. S5). The  $0.15\text{ mM-}\text{Al}_2\text{O}_3/\text{NiO}$  electrode exhibited spherical particles similar to those of the unmodified NiO electrode, accompanied by a slight increase in particle size, suggesting the formation of a thin  $\text{Al}_2\text{O}_3$  overlayer with an estimated thickness of  $\sim 4\text{ nm}$ . By contrast, the  $150\text{ mM-}\text{Al}_2\text{O}_3/\text{NiO}$  electrode showed substantial interparticle connections, obscuring the original spherical morphology of the NiO. This observation indicates that the deposition of excessive  $\text{Al}_2\text{O}_3$  fills the interparticle voids of the NiO layer. Thus, increasing the precursor concentration enables systematic control over the thickness of the  $\text{Al}_2\text{O}_3$  overlayer, consistent with previous observations of  $\text{Al}_2\text{O}_3$ -modified  $\text{TiO}_2$  electrodes for dye-sensitized solar cells.<sup>9</sup>

To evaluate the photoelectrochemical performance as a function of the  $\text{Al}_2\text{O}_3$  precursor concentration, **RuRe** was first immobilized onto the  $C\text{-Al}_2\text{O}_3/\text{NiO}$  electrodes (**RuRe/C- $\text{Al}_2\text{O}_3/\text{NiO}$** ). **RuRe/C- $\text{Al}_2\text{O}_3/\text{NiO}$**  can be prepared using a simple adsorption method, which is convenient for optimization purposes. Incident photon-to-current conversion efficiencies (IPCEs) were measured at  $-0.7\text{ V vs. Ag/AgCl}$  under monochromatic irradiation at  $460\text{ nm}$ . During photoelectrochemical  $\text{CO}_2$  reduction using **RuRe/NiO** with cathodic polarization, electrons are supplied from the counter electrode and cathodic polarization shifts the Fermi level of NiO toward more negative potentials. This shift results in increased band bending at the NiO/solution interface, thereby enhancing electron injection from the semiconductor into the molecular photocatalyst. As shown in Fig. S6, the IPCE increased with increasing  $C$ , reached a maximum at  $C = 1.5\text{ mM}$ , and decreased at higher concentrations. Under the optimized conditions, the IPCE was enhanced by a factor of approximately two compared with that of the unmodified NiO electrode. Although the adsorption amount of **RuRe** slightly increased because of the enhanced surface area resulting from  $\text{Al}_2\text{O}_3$  modification, no correlation was observed between the amount of adsorbed **RuRe** and the IPCEs (Table S1).

**RuRe/NiO** photocathodes have been reported to deactivate within 5 h because of detachment of the **RuRe** complex from the semiconductor surface, whereas poly-**RuRu'**/NiO electrodes exhibit substantially improved long-term stability.<sup>21</sup> On the basis of this enhanced durability, we chose poly-**RuRu'**/NiO as





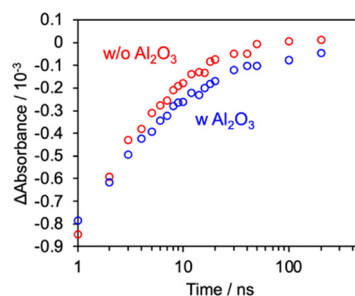
**Fig. 2** Time courses of CO, HCOOH, and H<sub>2</sub> evolution of (a) poly-RuRu'/0.15 mM Al<sub>2</sub>O<sub>3</sub>/NiO (w Al<sub>2</sub>O<sub>3</sub>) and (b) poly-RuRu'/NiO (w/o Al<sub>2</sub>O<sub>3</sub>). (c) Current–time curves for poly-RuRu'/0.15 mM Al<sub>2</sub>O<sub>3</sub>/NiO (w Al<sub>2</sub>O<sub>3</sub>), and poly-RuRu'/NiO (w/o Al<sub>2</sub>O<sub>3</sub>) under visible-light irradiation (32 mW cm<sup>-2</sup>, 460 nm < λ < 650 nm). The measurements were conducted in a 50 mM aqueous NaHCO<sub>3</sub> solution under a CO<sub>2</sub> or an Ar atmosphere (pH 6.6) and under an electrochemical bias of -0.7 V vs. Ag/AgCl. Irradiation area, 2.5 cm<sup>2</sup>.

a more suitable platform for evaluating the effect of Al<sub>2</sub>O<sub>3</sub> surface modification. As previously noted, molecular photocatalysts were immobilized onto the NiO surface *via* electrochemical polymerization (Fig. S7 and S8). The loading amount of electrochemically active poly-RuRu' on NiO was estimated from the Ru<sup>3+</sup>/Ru<sup>2+</sup> redox peaks observed in cyclic voltammograms to be approximately 18 nmol, irrespective of Al<sub>2</sub>O<sub>3</sub> modification (Fig. S9).

Photoelectrochemical CO<sub>2</sub> reduction was carried out using poly-RuRu'/0.15 mM Al<sub>2</sub>O<sub>3</sub>/NiO and poly-RuRu'/NiO electrodes at -0.7 V vs. Ag/AgCl in an aqueous NaHCO<sub>3</sub> solution under a CO<sub>2</sub> atmosphere. The electrodes were irradiated with visible light (460 nm < λ < 650 nm) using a 300 W Xe lamp equipped with a cutoff filter. CO and HCOOH were identified as the main reduction products, accompanied by a small amount of H<sub>2</sub> (Fig. 2). Notably, the amounts of CO and HCOOH produced were increased by approximately threefold upon Al<sub>2</sub>O<sub>3</sub> modification. Consistent with this enhancement, the photocurrent density of the poly-RuRu'/0.15 mM Al<sub>2</sub>O<sub>3</sub>/NiO electrode under irradiation was higher than that of the unmodified poly-RuRu'/NiO electrode. By contrast, under an Ar atmosphere, substantially lower photocurrents were observed, confirming that the observed photocurrent enhancement originates from CO<sub>2</sub> reduction. The action spectrum recorded at various excitation wavelengths was similar to the absorption spectrum of poly-RuRu'. Higher IPCEs were obtained at all wavelengths compared with the IPCEs of the unmodified electrode, with a maximum of 2.9 ± 0.5% observed at 460 nm (Fig. S10).

These results clearly demonstrate that the CO<sub>2</sub> reduction performance of the hybrid photocathode can be enhanced by inserting an Al<sub>2</sub>O<sub>3</sub> interlayer between the molecular photocatalyst and NiO. Although the flat-band potential ( $E_{\text{FB}}$ ) of a p-type semiconductor is known to influence the efficiency of electron transfer to an adsorbed photosensitizer,<sup>22</sup> the  $E_{\text{FB}}$  of NiO was found to remain essentially unchanged after the Al<sub>2</sub>O<sub>3</sub> modification (Fig. S11). This result indicates that the energetics of electron injection from the NiO to the molecular photocatalyst is not altered by the Al<sub>2</sub>O<sub>3</sub> layer. Therefore, the observed enhancement in CO<sub>2</sub> reduction activity is attributed to changes in charge carrier dynamics at the semiconductor/molecular interface induced by the Al<sub>2</sub>O<sub>3</sub> modification.

To gain insight into the role of the Al<sub>2</sub>O<sub>3</sub> interlayer, we analyzed the poly-RuRu'/0.15 mM Al<sub>2</sub>O<sub>3</sub>/NiO and poly-RuRu'/NiO photocathodes using *operando* transient absorption spectroscopy. Charge carrier dynamics under operating conditions were monitored at -0.7 V vs. Ag/AgCl in a CO<sub>2</sub>-saturated aqueous solution using 420 nm laser excitation. Upon pulsed photoexcitation, bleaching of the ground state was observed (Fig. S12). The bleaching signals, monitored at 465–470 nm for both electrodes, gradually recovered within several hundred nanoseconds (Fig. 3). This recovery is attributed to charge recombination between the one-electron-reduced photosensitizing unit and holes in the NiO and/or electron transfer from the photosensitizer to the catalytic unit. Notably, the recovery of the bleaching signal was delayed upon Al<sub>2</sub>O<sub>3</sub> modification, giving double exponential bleaching recovery rate constants of  $k_1 = 3.8 \times 10^8$  and  $k_2 = 2.7 \times 10^7$  s<sup>-1</sup>, which were smaller than those obtained without Al<sub>2</sub>O<sub>3</sub> modification ( $k_1 = 5.6 \times 10^8$  and  $k_2 = 6.7 \times 10^7$  s<sup>-1</sup>) (Fig. S12c). This delayed recovery clearly indicates suppression of back electron transfer between the semiconductor and the molecular photocatalyst by the Al<sub>2</sub>O<sub>3</sub> interlayer. The suppressed back electron transfer upon Al<sub>2</sub>O<sub>3</sub> modification was also supported by electrochemical impedance spectroscopy measurements (see Fig. S13).



**Fig. 3** Time-dependent absorbance changes in *operando* transient absorption measurements of poly-RuRu'/0.15 mM Al<sub>2</sub>O<sub>3</sub>/NiO (w Al<sub>2</sub>O<sub>3</sub>) and poly-RuRu'/NiO (w/o Al<sub>2</sub>O<sub>3</sub>) electrodes, monitored at 465–470 nm. The measurements were conducted in a 50 mM aqueous NaHCO<sub>3</sub> solution under a CO<sub>2</sub> atmosphere (pH 6.6) and under an electrochemical bias of -0.7 V vs. Ag/AgCl.



The transient absorption results indicate that an appropriately thin Al<sub>2</sub>O<sub>3</sub> layer formed by modification with a dilute precursor solution effectively suppresses undesirable charge recombination between the semiconductor and the molecular photocatalyst. The resultant enhancement in CO<sub>2</sub> reduction activity is therefore attributable to the suppression of recombination, increasing the availability of photogenerated electrons for CO<sub>2</sub> reduction. By contrast, excessive Al<sub>2</sub>O<sub>3</sub> deposition achieved through the use of more concentrated precursor solutions led to a decrease in photoelectrochemical performance.

Consistent with this trend, Guo *et al.* reported that the average electron injection rate from excited Re(I) and Ru(II) bipyridyl complexes into TiO<sub>2</sub> and SnO<sub>2</sub> decreases exponentially with increasing Al<sub>2</sub>O<sub>3</sub> overlayer thickness, as revealed by ultrafast transient infrared spectroscopy.<sup>11</sup> Guo *et al.* attributed this behavior to the formation of an overly thick insulating layer, which substantially hampered electron transfer. In the present system, a similar trade-off between suppression of back electron transfer and inhibition of forward electron injection is likely operative.

Our results demonstrate that precise control of interfacial electron transfer by tuning the Al<sub>2</sub>O<sub>3</sub> precursor concentration prior to dip coating is critical for maximizing the CO<sub>2</sub> reduction performance of NiO photocathodes. However, because electron transfer from the photosensitizing unit to the catalytic unit and back electron transfer from the reduced photosensitizer to the p-type semiconductor occur on comparable timescales (*i.e.*, on the order of microseconds), decoupling these processes experimentally remains challenging. As a result, quantitative evaluation of the back electron transfer rate as a function of the Al<sub>2</sub>O<sub>3</sub> precursor concentration has not yet been achieved. To address this limitation, we are currently constructing simplified model systems comprising only the semiconductor and the photosensitizing unit and are carrying out transient absorption measurements to further elucidate the underlying charge-transfer dynamics.

In summary, we have demonstrated that introducing an ultrathin Al<sub>2</sub>O<sub>3</sub> interlayer at the interface between a p-type NiO semiconductor and molecular photocatalysts effectively enhances visible-light-driven CO<sub>2</sub> reduction. By systematically tuning the Al<sub>2</sub>O<sub>3</sub> precursor concentration, we selectively suppressed charge recombination between NiO and the molecular photocatalyst without substantially impairing electron injection energetics. *Operando* transient absorption spectroscopy revealed that this interfacial modification prolongs the lifetime of the reduced photosensitizing unit, thereby increasing the number of electrons available for CO<sub>2</sub> reduction. Importantly, excessive Al<sub>2</sub>O<sub>3</sub> deposition was found to be detrimental, highlighting the critical balance between suppressing back electron transfer and maintaining efficient forward electron transport. These findings provide clear design principles for interfacial engineering in p-type semiconductor/molecular hybrid systems and open new avenues for improving the efficiency of photocathodes for solar-driven CO<sub>2</sub> conversion.

K. Maeda designed/supervised the project and wrote the manuscript draft with Y. T. and M. O. Y. T. conducted most of the experiments with assistance from T. T., J. O., M. T., and M. O. T. T., J. O. and O. I. designed and synthesized the Ru

complexes with Y. T. M. Y., K. Miyata and K. O. performed *operando* FT-IR measurements with Y. T. All authors reviewed the manuscript and approved its submission.

This work was supported by a Grant-in-Aid for Transformative Research Areas (A) “Supra-ceramics” (JP22H05142, JP22H05148, and JP25H01678) and a bilateral collaboration program (JPJSBP120237406) (JSPS). K. O. acknowledges financial support from the JSPS KAKENHI (JP23H01977 and JP23K20039). K. Miyata acknowledges support from the JSPS Transformative Research Areas (B) (JP23H03833).

## Conflicts of interest

There are no conflicts to declare.

## Data availability

The data supporting this article have been included as part of the supplementary information (SI). Supplementary information is available. See DOI: <https://doi.org/10.1039/d6cc00558f>.

## References

- 1 H. Gerischer, *Photochem. Photobiol.*, 1972, **16**, 243–260.
- 2 A. Hagfeldt, G. Boschloo, L. Sun, L. Kloo and H. Pettersson, *Chem. Rev.*, 2010, **110**, 6595–6663.
- 3 M. Watanabe, *Sci. Technol. Adv. Mater.*, 2017, **18**, 705–723.
- 4 A. Nakada, H. Kumagai, M. Robert, O. Ishitani and K. Maeda, *Acc. Mater. Res.*, 2021, **2**, 458–470.
- 5 C. D. Windle, H. Kumagai, M. Higashi, R. Brisse, S. Bold, B. Joussemme, M. Chavarot-Kerlidou, K. Maeda, R. Abe, O. Ishitani and V. Artero, *J. Am. Chem. Soc.*, 2019, **141**, 9593–9602.
- 6 G. Sahara, R. Abe, M. Higashi, T. Morikawa, K. Maeda, Y. Ueda and O. Ishitani, *Chem. Commun.*, 2015, **51**, 10722–10725.
- 7 G. Sahara, H. Kumagai, K. Maeda, N. Kaeffer, V. Artero, M. Higashi, R. Abe and O. Ishitani, *J. Am. Chem. Soc.*, 2016, **138**, 14152–14158.
- 8 Y. Yamazaki, H. Takeda and O. Ishitani, *J. Photochem. Photobiol., C*, 2015, **25**, 106–137.
- 9 E. Palomares, J. N. Clifford, S. A. Haque, T. Lutz and J. R. Durrant, *J. Am. Chem. Soc.*, 2003, **125**, 475–482.
- 10 W. Kim, T. Tachikawa, T. Majima and W. Choi, *J. Phys. Chem. C*, 2009, **113**, 10603–10609.
- 11 J. Guo, C. She and T. Lian, *J. Phys. Chem. C*, 2007, **111**, 8979–8987.
- 12 T.-C. Tien, F.-M. Pan, L.-P. Wang, C.-H. Lee, Y.-L. Tung, S.-Y. Tsai, C. Lin, F.-Y. Tsai and S.-J. Chen, *Nanotechnology*, 2009, **20**, 305201.
- 13 M. Law, L. E. Greene, A. Radenovic, T. Kuykendall, J. Liphardt and P. Yang, *J. Phys. Chem. B*, 2006, **110**, 22652–22663.
- 14 S. Uehara, S. Sumikura, E. Suzuki and S. Mori, *Energy Environ. Sci.*, 2010, **3**, 641–644.
- 15 Z. Bian, T. Tachikawa, S.-C. Cui, M. Fujitsuka and T. Majima, *Chem. Sci.*, 2012, **3**, 370–379.
- 16 G. Natu, Z. Huang, Z. Ji and Y. Wu, *Langmuir*, 2012, **28**, 950–956.
- 17 Z. Ji, M. He, Z. Huang, U. Ozkan and Y. Wu, *J. Am. Chem. Soc.*, 2013, **135**, 11696–11699.
- 18 S. Sumikura, S. Mori, S. Shimizu, H. Usami and E. Suzuki, *J. Photochem. Photobiol., A*, 2008, **199**, 1–7.
- 19 A. Bazyari, Y. Mortazavi, A. A. Khodadadi, L. T. Thompson, R. Tafreshi, A. Zaker and O. T. Ajenifujah, *Appl. Catal., B*, 2016, **180**, 312–323.
- 20 A. A. Bin Mokaizh, J. H. Shariffuddin, A. O. Baarimah, A. Al-Fakih, A. Mohamed, S. O. Baarimah, A. A. Al-Mekhlafi, H. Alenezi, O. A. Olalere and A. A. H. Saeed, *Materials*, 2022, **15**, 3046.
- 21 R. Kamata, H. Kumagai, Y. Yamazaki, M. Higashi, R. Abe and O. Ishitani, *J. Mater. Chem. A*, 2021, **9**, 1517–1529.
- 22 H. Kumagai, G. Sahara, K. Maeda, M. Higashi, R. Abe and O. Ishitani, *Chem. Sci.*, 2017, **8**, 4242–4249.

